

REMARKS/ARGUMENTS

Claim 1-2 are pending. Applicant appreciates acknowledgement of allowable subject matter.

Applicant has amended the term “in question” from the claims. From the claim language, the “first control module field *immediately adjoins the first edge* of the exposure field,” is specific, that is the location is “adjoined at the first edge of the exposure field.” Furthermore, reference numerals in the claims have been deleted.

Applicant believes the term “in question” does not raise issues of ambiguity. However, to expedite the Examination of present case, he has removed the term. Applicant directs Examiner to meaning of the phrase: “in question.” Review of “Dictionary.com” on the Internet shows the meaning of “in question,” as “*under consideration*.” This, Applicant believes, is a common usage of the phrase.

Page 1, lines 20-25 provides discussion, for example, “The known wafer is so designed that a first control module field of each exposure field immediately adjoins a first edge of the exposure field *in question* and that a second control module field of each exposure field immediately adjoins the second edge of the exposure field *in question*.” Substitute, “under consideration.”

Applicant believes he has addressed the Examiner’s concerns. A Notice of Allowance is earnestly requested.

Please charge any fees other than the issue fee and credit any overpayments to Deposit Account 50-4019.

Respectfully submitted,

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